## Notice of References Cited Application/Control No. 10/634,970 Examiner David M. Naff U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination HARRIS ET AL. Page 1 of 1

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|---|----------|---|--|--|--|--|
| * | U        | Kitaguchi et al., Tetrahedron Letters (1988), 29(43): 5487-5488.                          |  |  |  |  |
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